## Sample means in a typical set

• We define 
$$UCB_a(t) = \hat{\mu}_a(t) + \sqrt{\frac{2\log(T)}{N_a(t)}}$$
 and  $LCB_a(t) = \hat{\mu}_a(t) - \sqrt{\frac{2\log(T)}{N_a(t)}}$ 

• Using Hoeffding's inequality, we can prove:

$$\mathbb{P}\left(\text{ for all arm }a\text{ and iteration }t,\text{ }\text{LCB}_a(t)\text{ }<\mu_a\text{ }<\text{ }\text{UCB}_a(t)\text{ }\right)\text{ }\geq\text{ }1-\frac{1}{T}.$$

- ullet Maximum regret suffered over T iterations is T.
- Regret suffered outside the good event is bounded by  $\frac{1}{T} \times T = 1$ , which

contributes a constant. Hence we ignore everything outside the good event.

• Thus, we assume the sample means forever stay between the UCB and LCB for every arm.

## Sample means in a typical set

- From now on, we restrict ourselves to the good event where the actual mean is contained in the interval  $\left[ LCB_a(t), \ UCB_a(t) \right]$
- ullet An interesting observation: The interval  $\left[ {f LCB}_a(t), \ {f UCB}_a(t) \right]$  shrinks as we collect

more samples from arm a.

